



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

DAVID R. HEMBREE
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SALMAN AKRAM
ALAN G. WOOD
C. PATRICK DOHERTY
ANDREW J. KRIVY

Serial No. : 10/072,734

ART UNIT: 2829

Filing Date: 02/05/2002

Examiner: KARLSEN, E.

For: METHOD FOR TESTING
SEMICONDUCTOR WAFERS

Attorney Docket No. 96-750.3

AMENDMENT

August 28, 2003

Mail Stop Non Fee Amendment
Commissioner For Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This Amendment is in response to the Office Action dated 06/11/2003, having a statutory period for response set to expire on 09/11/2003.